NSN 6625-01-143-0226

Semiconductor Device Test Set - Page 1 of 1



View Online at https://aerobasegroup.com/nsn/6625-01-143-0226 Width: 10.000 inches **Major Components:** Cables to scope Depth: 9.000 inches **Inclosure Feature:** Single item w/housing **Test Type For Which Designed:** Semiconductor curve tracer **Operating Test Capability:** Meter range 0 to 100 volts dc Height: 4.000 inches **Surface Treatment:** Any acceptable Shelf Life: N/a **Unit Of Measure: Demilitarization:**

No **Fiig:** T228-a